

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/554,285	NASHIMOTO ET AL.	
Examiner	Art Unit	
Paul C. Martin	1657	6/26/07

SEARCHED					
Class	Subclass	Date	Examiner		
n/a	n/a		PCM		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
n/a	n/a		РСМ		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor name search PALM/EAST: EPO, JPO, DERWENT, USPATFULL, USPGPUBS	6/26/2007	РСМ		
EAST: EPO, JPO, DERWENT, USPATFULL, USPGPUBS	6/14/2007	РСМ		
Limited classification search: EAST: EPO, JPO, DERWENT, USPATFULL, USPGPUBS	6/26/2007	РСМ		
STN: REGISTRY, CAPLUS databases, Indexed BIOSCIENCE cluster(74 databases)	5/22/2007	РСМ		
STN: REGISTRY, CAPLUS, MEDLINE, BIOSIS, WPIDS databases	5/24/2007	РСМ		
STIC search	6/7/2007	РСМ		
Patentability conference; conferees: T. McKelvey SPE 1655, P. Leith Primary 1655 and P. Martin	6/14/2007	РСМ		
STIC serach	6/18/2007	РСМ		